

Search Notes

Application/Control No.

10/620,428

Examiner

Seung H. Lee

Applicant(s)/Patent under
Reexamination

CHIEN, TIEN-YUAN

Art Unit

2876

SEARCHED

Class	Subclass	Date	Examiner
235	380	3/15/2005	SHL
235	379	3/15/2005	SHL
902	9	3/15/2005	SHL
271	176	3/15/2005	SHL
271	181	3/15/2005	SHL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/15/2005	SHL
PCT cites	3/15/2005	SHL
NPL	3/15/2005	SHL
J. Hayes (705)	3/15/2005	SHL